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| FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 2 | ATTORNEY DOCKET NO. | SERIAL NO. |
| | 5077-000055/COA | |
| | APPLICANT | |
| | Akira Enokihara et al. | |
| | FILING DATE | GROUP |
| | Herewith | |

| U.S. PATENT DOCUMENTS | | | | | | |
|-----------------------|---------------------|-----------------|------------|------------------|-----------------|------------------------------|
| Ref. Desig. | Examiner's Initials | Document Number | Date | Name | Class/ Subclass | (If appropriate) Filing Date |
| 1. | DT | 5,874,870 | 02/23/1999 | Nishiyama et al. | 333/202 | |
| 2. | DT | 6,323,746 B1 | 11/27/2001 | Prager et al. | 333/219.1 | |
| 3. | DT | 6,255,917 B1 | 07/03/2001 | Scott | 29/527.2 | |
| 4. | DT | 6,169,467 B1 | 01/02/2001 | El-Sharawy | 333/219.1 | |
| 5. | DT | 5,805,033 | 09/08/1998 | Liang et al. | 333/202 | |
| 6. | DT | 4,963,841 | 10/16/1990 | Sparagna | 333/202 | |
| 7. | DT | 4,661,790 | 04/28/1987 | Gannon et al. | 333/234 | |
| 8. | DT | 4,639,699 | 01/27/1987 | Nishikawa et al. | 333/202 | |
| 9. | DT | 4,028,652 | 06/07/1977 | Wakino et al. | 333/209 | |
| 10. | DT | 4,725,798 | 02/16/1988 | Igarashi | 333/212 | |

| FOREIGN PATENT DOCUMENTS | | | | | | | |
|--------------------------|---------------------|-----------------|------------|---------|-----------------|-----------------------|--|
| Ref. Desig. | Examiner's Initials | Document Number | Date | Country | Class/ Subclass | Translation Yes No | |
| 1. | DT | 53-076747 A | 11/30/1976 | Japan | N/A | Partial | |
| 2. | DT | 63-110618 | 05/16/1988 | Japan | H01G 4/12 | Partial | |
| 3. | DT | 63-010603 A | 01/23/1988 | Japan | H01P 7/10 | Partial | |
| 4. | DT | 63284902 | 11/22/1988 | Japan | H01P 7/10 | Abstract | |
| 5. | DT | 63250201 | 10/18/1988 | Japan | H01A 7/10 | Abstract | |
| 6. | DT | 0 859 423 A1 | 08/19/1998 | Europe | H01P 1/208 | | |
| 7. | DT | 08065006 A | 03/08/1996 | Japan | H01P 1/20 | Abstract | |
| 8. | DT | 2000-114809 A | 04/21/2000 | Japan | H01P 1/205 | Abstract | |

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| Examiner: <i>Don Gohaka</i> | Date Considered: 9/20/04 |
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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| <p>FORM HDP-1449 (Based on Form PTO-1449)</p> <p>PATENT AND TRADEMARK OFFICE</p> <p>INFORMATION DISCLOSURE CITATION</p> <p>(Use several sheets if necessary)</p> <p>Sheet 2 of 2</p> | ATTORNEY DOCKET NO. | SERIAL NO. |
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| | Herewith | |

| OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.) | | |
|--|---------------------|---|
| Ref. Desig. | Examiner's Initials | |
| 1. | DT | Farhat Abbas et al., "Ultra-high-Q resonators for low-noise, microwave signal generation using sapphire buffer layers and superconducting thin films"; Superconductor Science and Technology; Vol. 7, No. 7; July 1, 1994; pp. 495-501. |
| 2. | DT | Notice of Reasons of Rejection for Patent Application No. 2001-176674 and English Translation; Mailed September 24, 2003. |

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| Examiner:  | Date Considered: 9/20/04 |
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